Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,517	ISHIGURO ET AL.	
Examiner	Art Unit	
Tu X. Nguyen	2618	

SEARCHED					
Class	Subclass	Date	Examiner		
455	69	1/3/2007	TN		
	522				
	523				
	506				
370	. 311	•			
	349				
	335				
<u> </u>					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

(INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
Search East	1/3/2007	TN